

## **Report to IEEE SWC, S/C: ADSCOM**

### **WG PC37.301, Philadelphia, PA, 16 October 2007**

#### **1. Meeting**

Meeting was from 8h00 to 9h45; 9 members and 19 guests participate.

Patent slides have been shown. No patent issues have been raised.

The new PAR, on the adoption of IEC 60270 have been adopted and the old PAR withdrawn.

#### **2. Discussions**

- François Soulard accepted to be assigned as co-chair.
- Jodi Haasz, from the IEEE headquarter gave a short description of the format of the document. She will send an example to the chair. This model will be use for next draft.
- The main part of the document will be the IEC standard 60270. A normative annex will cover the test procedures and the conditioning of test objects and an informative annex will cover PD pattern recognitions.
- Only the general tests procedures for switchgears will be covered. The particular concerns or procedures for specific products should be covered by the product standards. The PD limits, or the acceptance criteria, shall be covered by product standards.

#### **3. Course of action**

- Members and guests shall send their comments before end of November 2007.
- Draft to be circulated in the WG for end of January 2008.
- First ballot should be started or completed before the spring meeting (may 2008)

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